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Please amend the application as follows:

## In the Specification:

On page 5, in the paragraph beginning at line 10, please delete the paragraph and insert the following:

- Advantages of the disclosed methods and structures, in various embodiments, can include one or more of the following:
- -more test structures can be made larger;
- -quicker correction of process deviations;
- -increased efficiency of use of wafer area;
- -increased efficiency of use of scribeline area;
- -fewer probe pads are needed;
- -increased yield;
- -increased capability for "early warning" testing increases reliability of the integrated circuits.--

## In the Abstract:

Please delete the Abstract and insert the following: